Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,860	DE ROO ET AL.
Examiner	Art Unit
Brian Ensey	2646

	SEAR	CHED	
Class	Subclass	Date	Examiner
381	170	11/30/05	36
	170	ſ	
	337		
	338		
	356		
	357		
	358		
V	359	V	
381	389	12/2/05	36

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			:	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
INVENTOR SCARCH ERST. 4 EDAM	11/30/05	134	
SCARCHED EAST BRS, ISAR + TEXT	11/30/05	36	
DISUVSSED WITH HUYEV LC	11/30/05	36	
DISCUSSED WITH SUHIAN NF	12/1/05	32	